Sear	cn Notes	

Application/Control No.	Applicant(s)/Patent under Reexamination		••
10/531,454	DERIE ET AL.	DERIE ET AL.	
Examiner	Art Unit	Art Unit	
John Kreck	3673	3673	

SEARCHED			
Class	Subclass	Date	Examiner

INTERFERENCE SEARCHED			
Class	Subclass	Date	Examiner
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SEARCH NO (INCLUDING SEARC	SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
	DATE	EXMR	
EAST text seach attached	3/13/2006	JK	